IN THE CLAIMS

Please enter the below claim amendments.

1. (currently amended) A system, comprising:

a table comprising [[at]] a first timing adjustment signal associated with a rank of a memory component and a second timing adjustment signal associated with the memory component;

a pipeline for imparting a gross timing delay for adjusting [[the]] a data strobe signal associated with the memory component using a first portion of the first timing adjustment signal; and

a memory cell connected to the pipeline operable for:

receiving at least a second portion of the first timing adjustment signal; and

further adjusting the data strobe signal using the second portion by an amount less than the amount of the first portion.

- 2. (currently amended) The system of claim 1 further comprising a process module for measuring [[the]] a distribution rate of the data strobe signal and [[the]] a rate of a data bit arrival time across the memory component.
- 3. (original) The system of claim 2 further comprising a read data buffer operable for receiving the read data from the memory component and outputting the read data.
- (currently amended) The system of claim 1, further comprising:

a finite state machine (FSM) operable for determining the rank of at least one memory component from an address associated with the data to be read from the memory component.

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- 5. (original) The system of claim 1, wherein the memory component is a dual data-rate (DDR) memory component.
- 6. (currently amended) The system of claim 1, wherein the first portion adjusts the data strobe by multiples of a clock pulse, and wherein the second portion adjusts [[the]] a position of the data strobe signal by fractions of the clock pulse.
- 7. (original) The system of claim 1, wherein the second timing adjustment signal is operable for adjusting the data strobe signal.

- 8. (currently amended) The system of claim 1, wherein the memory cell[[s]] comprises: an adjustable pipeline for receiving second portion of the first adjustment signal; a pulse stretch circuit for generating a gating signal for the data strobe signal; a logical gate for combining the gating signal with the data strobe signal from the
- a logical gate for combining the gating signal with the data strobe signal from the memory component to produce a gated data strobe signal;
 - a delay clock circuit operable for:
 - imparting a predefined time delay on the gated data strobe signal; and adjusting the timing of the data strobe to coincide with [[the]] a data pulse; and a logic gate for reading out the data.
- 9. (original) The system of claim 1, wherein the table is located in a memory controller hub (MCH).
- 10. (original) The system of claim 1, wherein the table is located within the memory component.
- 11. (currently amended) A method, comprising:

calculating [[$\frac{1}{1}$ a rank of the DDR memory component from a command tenure;

extracting at least one timing adjustment signal from a look-up table associated with the calculated rank; and

using the at least one timing adjustment signal to adjust a gating circuit for gating a data strobe signal to account for timing variations for reading data in a memory component.

12. (currently amended) The method of claim 11, further comprising

extracting a second timing adjustment signal from the look-up table associated with the calculated rank and memory component; and

using the second timing adjustment signal to synchronize the gated data strobe signal with [[the]] a data signal.

- 13. (currently amended) The method of claim 11, wherein the command tenure comprises a read command and an address associated with the data.
- 14. (original) The method of claim 11 wherein the at least one timing adjustment signal comprises a first portion and a second portion,

wherein the first portion is used to grossly adjust the gating signal using integer multiples of a clock signal, and

wherein the second portion is used to finely adjust the position of the gating signal using

fractions of the clock signal.

- 15. (original) The method of claim 11, further comprising: shifting the gated data strobe signal by ¼ of a clock pulse.
- 16. (original) The method of claim 15, further comprising: using the shifted data strobe signal to trigger a flip-flop for reading the data.
- 17. (currently amended) A memory cell; comprising:
 - an adjustable pipeline operable for:
- receiving a fractional portion of a first adjustment signal, the fractional portion having a first value; and
- adjusting timing of a gating signal by a length of time equal to the value of the fractional portion of the first adjustment signal;
 - a pulse stretch circuit for stretching the gating signal in time;
- a logical gate for combining the stretched gating signal with a data strobe signal from a targeted memory component to produce a gated data strobe signal;
 - a delay clock circuit operable for:
 - imparting a predefined time delay on the gated strobe signal; and
- adjusting the timing of the delayed data strobe signal to coincide with [[the]] a read data pulse; and
 - a circuit for reading out the data.
- 18. (original) The memory cell of claim 17, wherein the delay clock circuit is further operable for
- receiving a second adjustment signal having a predefined value; and
 using the predefined value of the second adjustment signal to adjust the time of
 the delayed data strobe signal.
- 19. (original) The memory cell of claim 17, wherein the predefined delay is equal to ¼ of a system clock pulse.
- 20. (currently amended) The memory cell of claim 19, wherein the value of the fractional portion of the first adjustment signal comprises a fraction portion of the system clock pulse.